0.2		3		<u>, </u>	ota i				
FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. 169.1957	APPLICATION NO. 09/755,068					
LIST OF REFERENCES CITED BY APPLICANT(S)		APPLICANT(S)	APPLICANT JING WU E	ET AL.					
	(Use several sheets if nece	issary)	FILING DATE January 8, 2001						
		· · · · · · · · · · · · · · · · · · ·	U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE			
K	5,995,095	11/30/99	Ratakonda	345 328					
		+	OIA	+					
			FEB 2 6 2001 . 8	-					
			(型 2007)						
			TRADEMARK OFFI						
				+					
			FOREIGN PATENT DOCUMENTS						
	DOO! IN AFAIT	DATE			31.201400	TRANSLATION			
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	YES/NO/ OR ABSTRACT			

		OTHER DOCUM	AENT/S) (Including Author Title Date Partinent Pages Etc.)						
	Y T Tse. et		MENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.) Zoom/Pan Estimation and Compensation	on for Vi	don Comi	proceion "			
	Proc ICASS	Y. T. Tse, et al., "Global Zoom/Pan Estimation and Compensation for Video Compression," Proc ICASS-91, Vol. 4: Multidimensional Signal Processing, IEEE, Ontario, Canada (1991), pp. 2725-2728							
	A.K. Jain, "I Cliffs, N.J. (A.K. Jain, "Fundamentals of Digital Image Processing," Prentice Hall, Inc., Englewood Cliffs, N.J. (1989), Contents and pp. 381-390							
									
				_		· .			
EXAMINER	_Y. Let	<u>e</u>	DATE CONSIDERED 6///	04					

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO 144			MERCE PE	<u> </u>	TY DOCKET NO C169.00195			APPLICATION 09/755,0		
LIST		PARTMENT OF COM AND TRADEMARK RENCES CITED BY several sheets if nece	OFFICE ANTES	~ \ II	PLICANT ING WU, E	ΓAL.	•	,	•	
SEP				FILING DATE January 8, 2002			GROUP 26/3			
			TRAD TRAD	U.S.	PATENT DOCU	MENTS		~~ .		
*EXAMINER .INITIAL		DOCUMENT NUMBER	DATE			NAME			SUBCLASS	FILING DATE IF APPROPRIATE
-						,				
		- 4								
			***	**			RE	CEI	VI	
· · · · · · · · · · · · · · · · · · ·					-		J.	P 1 9	2002	
	:					.,.	Technol	gy Cen	er 2100	
						· · · · · ·				
	·			FOREIG	ON PATENT DOC	CUMENTS		· · · · · · · · · · · · · · · · · · ·		
		DOCUMENT NUMBER	DATE		CC	DUNTRY		CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
1	·	98/52356	11/19/98		Au	stralia		,		_
									. — —	
								ECEN	}	
								EP 2 6		
							Tech	nology ve	nter 2600	
			OTHER DOCUM	ENT(S) (Inc	luding Author, Ti	tle, Date, Pertinent F	ages, Etc.)			

								:		
EXAMINER	Y	Le:	e		DATE CONS	SIDERED	6/1	104		

Sheet_1_ of _1__

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO 1449 (modified)			ATTY DOCKET NO. 00169.001957.	APPLICATION NO. 09/755,068				
	U.S. DEPARTMENT OF COM PATENT AND TRADEMARK OF REFERENCES CITED BY (Use several sheets if nece	/()						
(6		FEB 2 0. 2004 2	V		GROUP 26/3			
		P. R.	U.S. PATENT DOCUMENTS					
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE		
			4v					
				Bace dense				
				HE	B 2 3 20			
				Techno.	togy Cente			
				IGOIIIO	ingy ocini	JI 2100		
			ADEIGNI DATENT DOGUMENTO					
		FC	REIGN PATENT DOCUMENTS		<u> </u>	TDANIOLATION		
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT		
	889 652	01/07/99	Europe			-		
	2,308,774	07/02/97	Great Britain					
			•					
		OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)					
EXAMINER	Y. Lee		DATE CONSIDERED 6/1/	04				

Sheet 1 of 1

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.